







TEST REPORT

Test report no.: 1-6160/13-01-26



Testing laboratory

CETECOM ICT Services GmbH

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Accredited Testing Laboratory:

The testing laboratory (area of testing) is accredited according to DIN EN ISO/IEC 17025 (2005) by the Deutsche Akkreditierungsstelle GmbH (DAkkS)

The accreditation is valid for the scope of testing procedures as stated in the accreditation certificate with

the registration number: D-PL-12076-01-00

Applicant

Pegatron Corporation

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11261 Taipei City / TAIWAN Fax: +88 68 99 48 82 38

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e-mail: <u>brian3 chen@pegatroncorp.com</u>

Phone: +88 64 37 02 22 33

Manufacturer

Pegatron Corporation

5F, No. 76, Ligong Street Beitou District

11261 Taipei City / TAIWAN

Test standard/s

47 CFR Part 15 Title 47 of the Code of Federal Regulations; Chapter I; Part 15 - Radio frequency

devices

RSS - 210 Issue 8 Spectrum Management and Telecommunications Radio Standards Specification -

Licence-exempt Radio Apparatus (All Frequency Bands): Category I Equipment

For further applied test standards please refer to section 3 of this test report.

Test Item

Kind of test item: Car Media System

Model name:SDIS1FCC ID:VUISDIS1IC:7582A-SDIS1Frequency:13.56 MHzTechnology tested:RFID / NFC

Antenna: Integrated loop antenna

Power supply: 12V DC

Temperature range: -20°C to +50°C



This test report is electronically signed and valid without handwriting signature. For verification of the electronic signatures, the public keys can be requested at the testing laboratory.

Test report authorised:	Test performed:
Marco Bertolino Specialist	David Lang Specialist
Radio Communications & EMC	Radio Communications & EMC



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2 General information

2.1 Notes and disclaimer

The test results of this test report relate exclusively to the test item specified in this test report. CETECOM ICT Services GmbH does not assume responsibility for any conclusions and generalizations drawn from the test results with regard to other specimens or samples of the type of the equipment represented by the test item.

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This test report is electronically signed and valid without handwritten signature. For verification of the electronic signatures, the public keys can be requested at the testing laboratory.

2.2 Application details

Date of receipt of order: 2013-08-21
Date of receipt of test item: 2014-10-07
Start of test: 2014-10-28
End of test: 2014-11-04

Person(s) present during the test: -/-

3 Test standard/s

Test standard	Date	Test standard description
47 CFR Part 15	-/-	Title 47 of the Code of Federal Regulations; Chapter I; Part 15 - Radio frequency devices
RSS - 210 Issue 8	01.12.2010	Spectrum Management and Telecommunications Radio Standards Specification - Licence-exempt Radio Apparatus (All Frequency Bands): Category I Equipment



4 Test environment

 $\begin{array}{ccc} & & T_{nom} & +22 \ ^{\circ}\text{C during room temperature tests} \\ \text{Temperature:} & & T_{max} & +50 \ ^{\circ}\text{C during high temperature tests} \end{array}$

T_{min} -20 °C during low temperature tests

Relative humidity content: 55 %

Barometric pressure: not relevant for this kind of testing

V_{nom} 12 V DC

Power supply: V_{max} -/- V

V_{min} -/- V

5 Test item

Kind of test item	:	Car Media System	
Type identification	:	SDIS1	
S/N serial number	:	Prototype #7	
HW hardware status	:	C101	
SW software status	:	SDIS1R_0.344_dev_AU_ER_sdis1_er-userdebug	
Frequency band [MHz]	:	13.56 MHz	
Type of radio transmission	:	single carrier	
Use of frequency spectrum	:		
Number of channels	:	1	
Antenna	:	Integrated loop antenna	
Power supply	:	12 V DC	
Temperature range	:	-20°C to +50 °C	

5.1 Additional information

The content of the following annexes is defined in the QA. It may be that not all of the listed annexes are necessary for this report, thus some values in between may be missing.

Test setup- and EUT-photos are included in test report: 1-6160/13-01-01_AnnexA

1-6160/13-01-01_AnnexB 1-6160/13-01-01_AnnexC

6 Test laboratories sub-contracted

None



7	Summary of measu	rement results
		No deviations from the technical specifications were ascertained
		There were deviations from the technical specifications ascertained

TC Identifier	er Description		Date	Remark
RF-Testing	CFR Part 15	Passed 2014-11-04		-/-
1xi - i esting	RSS 210, Issue 8, Annex 2.6	Passed	2014-11-04	-/-

Test Specification Clause	Test Case	Temperature Conditions	Power Source Voltages	Pass	Fail	NA	NP	Remark
§ 15.35 (c)/ RSS-GEN Issue 3	Timing of the transmitter (Duty cycle correction factor)	Nominal	Nominal					complies
RSS-GEN Issue 3	99 % emission bandwidth	Nominal	Nominal					complies
§ 15.225 (a)/ RSS-210 Issue 8 Annex 2.6	Fieldstrength of Fundamental	Nominal	Nominal					complies
§ 15.209/ RSS-210 Issue 8 Annex 2.6	Fieldstrength of harmonics and spurious	Nominal	Nominal	\boxtimes				complies
§ 15.225 (e)/ RSS-210 Issue 8	Fraguency telerones	Nominal	Extreme	\boxtimes				complies
Annex 2.6	Frequency tolerance	Extreme	Nominal					complies
§15.107 §15.207	Conducted emissions < 30 MHz	Nominal	Nominal					complies*

Note:

NA = Not Applicable; NP = Not Performed *Since no AC/DC adaptor had been provided by the customer the test was conducted using an ordinary travel charger (Brand: Samsung; Model: SAC-48; SN: 0016A).



8 Additional comments

Reference documents: None

Special test descriptions: None

Configuration descriptions: None



9 Measurement results

9.1 Timing of the transmitter

Measurement:

Measurement parameter				
Detector:	Positive peak			
Sweep time:	100 ms			
Resolution bandwidth:	100 kHz			
Video bandwidth:	300 kHz			
Span:	Zero span			
Trace-Mode:	Single sweep			

Limits:

FCC	IC			
Timing of the transmitter				

(c) Unless otherwise specified, e.g. Section 15.255(b), when the radiated emission limits are expressed in terms of the average value of the emission, and pulsed operation is employed, the measurement field strength shall be determined by averaging over one complete pulse train, including blanking intervals, as long as the pulse train does not exceed 0.1 seconds. As an alternative (provided the transmitter operates for longer than 0.1 seconds) or in cases where the pulse train exceeds 0.1 seconds, the measured field strength shall be determined from the average absolute voltage during a 0.1 second interval during which the field strength is at its maximum value. The exact method of calculating the average field strength shall be submitted with any application for certification or shall be retained in the measurement data file for equipment subject to notification or verification.

Result:

100%



9.2 Field strength of the fundamental

Measurement:

Measurement parameter			
Detector:	Quasi Peak		
Resolution bandwidth:	200 Hz up to 150 kHz, 9 kHz up to 30 MHz, 120 kHz up to 1 GHz		
Video bandwidth:	≥ RBW		
Trace-Mode:	Max Hold		

Limits:

FCC		IC		
Fundamental Frequency (MHz) Field strength of (µV/m / dE			Measurement distance (m)	
	15848 μV/m (84 dBµV/m)	30	
13.553 to 13.567	158489 (104 dB	•	10 (Recalculated acc. to FCC part15.31 (f2)	

Result:

TEST CO	NDITIONS	MAXIMUM POWER (dBμV/m)		
Frequ	uency	13.56 MHz 13.56 MHz		
Mo	ode	@ 10 m distance	@ 30 m distance	
T _{nom}	V _{nom}	35 15		
Measuremen	nt uncertainty	±30	dB	

^{*} Limits recalculated from 10m to 30m with 40 dB/decade according to FCC 15.31 (f2).



9.3 99 % emission bandwidth

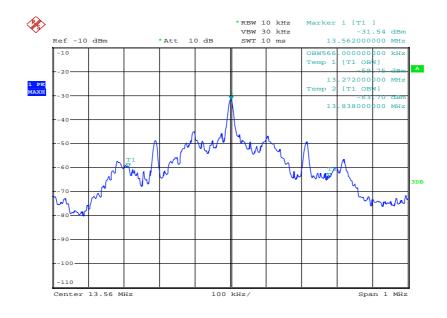
Measurement:

Measurement parameter				
Detector:	Peak			
Resolution bandwidth:	> 1 % span			
Video bandwidth:	≥ RBW			
Trace-Mode:	Max Hold			

Results:

TEST CO	ONDITIONS	99 % emission bandwidth (kHz)		
Free	quency	13.56 MHz		
T _{nom} V _{nom}		566		
Measureme	ent uncertainty	± RBW		

Plot:



Date: 4.NOV.2014 11:25:33



9.4 Field strength of the harmonics and spurious

Measurement:

Measurement parameter				
Detector:	Quasi Peak / Average			
Sweep time:	Auto			
Resolution bandwidth:	F < 150 kHz: 200 Hz 150 kHz > F > 30 MHz: 9 kHz F > 30 MHz: 120 kHz			
Video bandwidth:	F < 150 kHz: 1 kHz 150 kHz > F > 30 MHz: 100 kHz F > 30 MHz: 300 kHz			
Span:	See plots!			
Trace-Mode:	Max hold			

Limits:

FCC		IC		
Fie	eld strength of the ha	rmonics and spu	urious.	
Frequency (MHz)	Field streng	jth (μV/m)	Measurement distance (m))
0.009 - 0.490	2400/F	(kHz)	300	
0.490 - 1.705	24000/F	(kHz)	30	
1.705 – 30	30 (29.5 c	BμV/m)	30	
30 – 88	100 (40 d	BμV/m)	3	
88 – 216	150 (43.5	dBμV/m)	3	
216 – 960	200 (46 d	BμV/m)	3	

Result:

	EMISSION LIMITATIONS					
f [MHz]	Detector	Limit max. allowed [dBµV/m]	Amplitude of emission [dBµV/m]	Results		
	No peaks detected.					

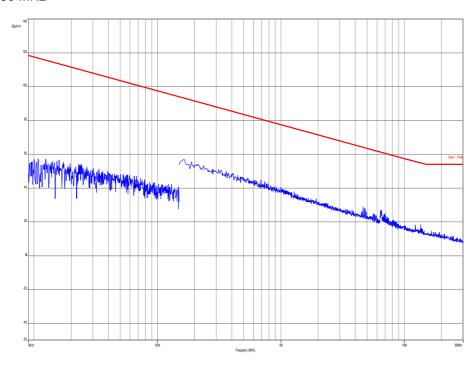
Verdict: passed

Note: The limit was recalculated with 20 dB / decade (Part 15.31) for all radiated spurious emissions 30 MHz to 1 GHz from 3 meter limit to a 10 meter distance. (40dB/decade for emissions < 30MHz)

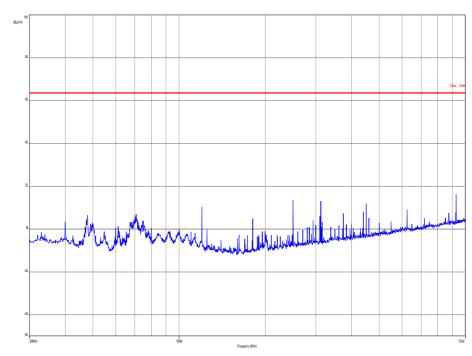


Plots of the measurements:

Plot 1: 9 kHz – 30 MHz



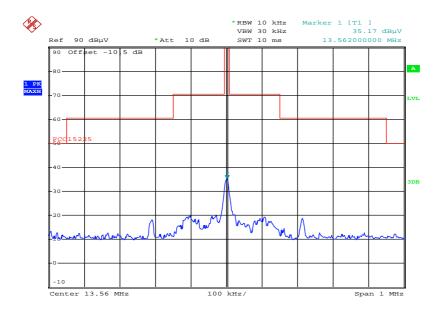
Plot 2: 30 MHz – 1000 MHz, vertical & horizontal polarization





Plot 3: Spectrum mask

Limits recalculated from 30 m to 10 m with 40 dB/decade according to FCC 15.31 (f2)



Date: 4.NOV.2014 11:20:09



9.5 Frequency tolerance

Measurement:

Measurement parameter				
Detector:	Positive peak			
Sweep time:	Auto			
Resolution bandwidth:	10 Hz			
Video bandwidth:	1 MHz			
Span:	1 kHz			
Trace-Mode:	Clear – write			

Limits:

FCC IC

The frequency tolerance of the carrier signal shall be maintained within +/- 0.01% of the operating frequency over a temperature variation of -20 degrees to +50 degrees C at normal supply voltage, and for a variation in the primary supply voltage from 85% to 115% of the rated supply voltage at a temperature of 20 degrees C.

For battery operated equipment, the equipment tests shall be performed using a new battery.

Results:

	Frequency tolerance							
Over temperature variation Over voltage variation								
Lir	nit is +/- 1.356	kHz	Lin	nit is +/- 1.356	kHz		-/-	
T (°C)]	Frequency	result	Power voltage	Frequency	result	F [MHz]	Detector	Level [µV/m]
-20°	13.560	Pass	12 V*	13.560	Pass			
-10°	13.560	Pass	10.2 V*	13.560	Pass			
0°	13.560	Pass						
10°	13.560	Pass						
20°	13.560	Pass					-/-	
30°	13.560	Pass						
40°	13.560	Pass						
50°	13.560	Pass						
55°	13.560	Pass						
Measurement uncertainty ±100 Hz								

^{*} Test was performed with a fully charged battery and repeated with 85% of the max battery voltage (estimated by battery indication display).



9.6 AC line conducted

Measurement:

Measurement parameter					
Detector:	Peak / Quasi peak / Average				
Sweep time:	Auto				
Resolution bandwidth:	F < 150 kHz: 200 Hz				
resolution bandwidth.	F > 150 kHz: 9 kHz				
Video bandwidth:	F < 150 kHz: 1 kHz				
video baridwidtii.	F > 150 kHz: 100 kHz				
Span:	9 kHz to 30 MHz				
Trace-Mode:	Max hold				

Limits:

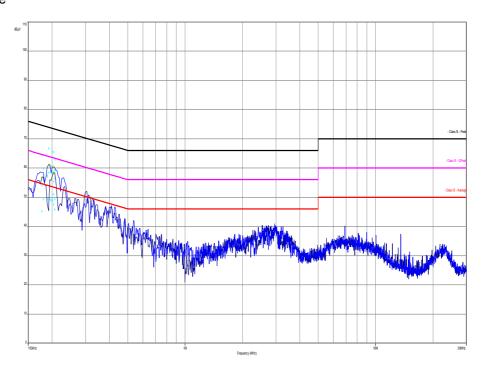
FCC	IC			
Frequency of Emission (MHz)	Conducted Limit (dBµV)			
	Quasi-peak	Average		
0.15 – 0.5	66 to 56 * 56 to 46 *			
0.5 – 5	56 46			
5 - 30	60	50		

<u>Verdict:</u> passed

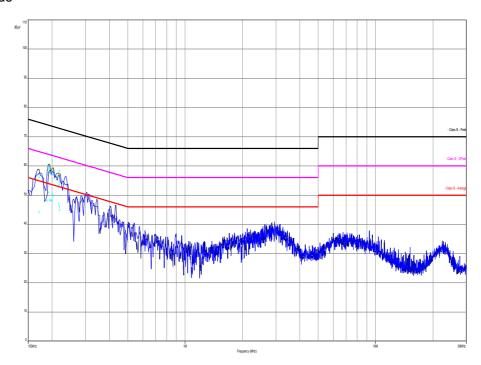


Plots:

Plot 1: Tx mode



Plot 2: Idle mode





10 Test equipment and ancillaries used for tests

Typically, the calibrations of the test apparatus are commissioned to and performed by an accredited calibration laboratory. The calibration intervals are determined in accordance with the DIN EN ISO/IEC 17025. In addition to the external calibrations, the laboratory executes comparison measurements with other calibrated test systems or effective verifications. Weekly chamber inspections and range calibrations are performed. Where possible, rf-generating and signalling equipment as well as measuring receivers and analyzers are connected to an external high-precision 10 MHz reference (GPS-based or rubidium frequency standard).

In order to simplify the identification of the equipment used at some special tests, some items of test equipment and ancillaries can be provided with an identifier or number in the equipment list below (Lab/Item).

No.	Lab / Item	Equipment	Туре	Manufact.	Serial No.	INV. No Cetecom	Kind of Calibration	Last Calibration	Next Calibration
11	n. a.	Double-Ridged Waveguide Horn Antenna 1-18.0GHz	3115	EMCO	8812-3088	300001032	vlKI!	08.05.2013	08.05.2015
2	n. a.	Anechoic chamber	FAC 3/5m	MWB / TDK	87400/02	300000996	ev		
3	n. a.	Switch / Control Unit	3488A	HP Meßtechnik	*	300000199	ne		
4	90	Active Loop Antenna 10 kHz to 30 MHz	6502	Kontron Psychotech	8905-2342	300000256	k	13.06.2013	13.06.2015
5	n. a.	Amplifier	js42-00502650-28- 5a	Parzich GMBH	928979	300003143	ne		
6	n. a.	TRILOG Broadband Test-Antenna 30 MHz - 3 GHz	VULB9163	Schwarzbeck	371	300003854	vIKI!	29.10.2014	29.10.2017
7	n. a.	MXE EMI Receiver 20 Hz bis 26,5 GHz	N9038A	Agilent Technologies	MY51210197	300004405	k	13.03.2014	13.03.2015
8	n. a.	4U RF Switch Platform	L4491A	Agilent Technologies	MY50000037	300004509	ne		
9	45	Switch-Unit	3488A	HP Meßtechnik	2719A14505	300000368	g		
10	n. a.	EMI Test Receiver	ESCI 3	R&S	100083	300003312	k	27.01.2014	27.01.2015
11	n. a.	Funkstörmessempfä nger 20Hz- 26,5GHz	ESU26	R&S	100037	300003555	k	28.02.2014	28.02.2015
12	n. a.	Antenna Tower	Model 2175	ETS-LINDGREN	64762	300003745	izw		
13	n. a.	Positioning Controller	Model 2090	ETS-LINDGREN	64672	300003746	izw		
14	n. a.	Turntable Interface- Box	Model 105637	ETS-LINDGREN	44583	300003747	izw		
15	n. a.	TRILOG Broadband Test-Antenna 30 MHz - 3 GHz	VULB9163	Schwarzbeck	295	300003787	k	22.04.2014	22.04.2016
16	n. a.	Signal Analyzer 20Hz-26,5GHz-150 to + 30 DBM	FSiQ26	R&S	835111/0004	300002678	Ve	15.01.2013	15.01.2015
17	n. a.	Temperature Test Chamber	T-40/50	CTS GmbH	064023	300003540	Ve	26.09.2013	26.09.2015
18	9	Artificial Mains 9 kHz to 30 MHz	ESH3-Z5	R&S	828576/020	300001210	Ve	30.01.2014	30.01.2016
19	9	Isolating Transformer	MPL IEC625 Bus Regeltrenntravo	Erfi	91350	300001155	ne		

Agenda: Kind of Calibration

k calibration / calibrated EK limited calibration

ne not required (k, ev, izw, zw not required) zw cyclical maintenance (external cyclical maintenance)

ev periodic self verification izw internal cyclical maintenance
Ve long-term stability recognized g blocked for accredited testing

vlkl! Attention: extended calibration interval
NK! Attention: not calibrated *) next calibration ordered / currently in progress

11 Observations

No observations except those reported with the single test cases have been made.



Annex A Document history

Version	Applied changes	Date of release
	Initial release	2014-11-04

Annex B Further information

Glossary

AVG - Average

DUT - Device under test

EMC - Electromagnetic Compatibility

EN - European Standard EUT - Equipment under test

ETSI - European Telecommunications Standard Institute

FCC - Federal Communication Commission

FCC ID - Company Identifier at FCC

HW - Hardware
IC - Industry Canada
Inv. No. - Inventory number
N/A - Not applicable
PP - Positive peak
QP - Quasi peak
S/N - Serial number



Annex C **Accreditation Certificate**

Front side of certificate

Back side of certificate

(DAkkS

Deutsche Akkreditierungsstelle GmbH

Bellehene gemäß § 8 Absatz 1 AkkStelleG i.V.m. § 1 Absatz 1 AkkStelleGBV Unterzeichnerin der Multilateralen Abkommen von EA, ILAC und IAF zur gegunseitigen Anerkennung

Akkreditierung



Die Deutsche Akkreditierungsstelle GmbH bestätigt hiermit, dass das Prüflaboratorium

CETECOM ICT Services GmbH Untertürkheimer Straße 6-10, 66117 Saarbrücken

dir Kampetanz nach DIN EN ISO/IEC 17025;2005 besitzt, Prüfungen in folgenden Bereichen durchzuführen:

Drahtgebundene Kommunikation einschließlich xDSL VolP und DECT Akustik

Akustik

Funk einschließlich WLAN
Short Range Devices (SRD)

RFID

WIMAx und Richtfunk
Mobilfunk (SBM) / DCS, Over the Air (OTA) Performance)
Elektromagnetische Verträglichkeit (EMV) einschließlich Auto
Produktsicherheit

SAR und Hearing Aid Compatibility (HAC)
Umweltsimulation
Smart Card Terminals
Bluetooth
WI-FI- Services

Die Aldreditierungsurkunde gilt nur in Verbindung mit dem Bescheld vom 07.03.2014 mit der Akkreditierungsnurmen D-PI-12076-01 und ist gillig 17.01.2018. Sie besteht aus diesem Deckblatt, de Rückseite des Deckblatts und der folgenden Anlage mit Insgesamt 77 Seiten.

Frankfurt am Main, 07.03.2014

Deutsche Akkreditierungsstelle GmbH

Standort Berlin Spittelmarkt 10 10117 Berlin

Standort Frankfurt am Main Gartenstraße 6 60594 Frankfurt am Main

38116 Braunschweig

Die Akkreditierung erfolgte gemößt der Gesetzes über die Akkreditierungsstelle (AkkfelleG) vom 31. Juli 2009 (BGRI, I.S. 2025) soeie der Veronfrung (GG) Nr. 755/2008 des Europäitschen Parlaments und des Bates vom 9. Juli 2008 über die Verschriften für die Akkreditierung und Marktüberwachung im Zusammenstallung mich der Veranstung von 9. Juli 2008, So. 30. Die DAKS ist Untwerderheitung und Marktüberwachung der European ein der Veranstung von 9. Juli 2008, So. 30. Die DAKS ist Untwerderheitung der Auffaltenban Abkammen unz gegenseltigen Anselwennung der European ein gegenseltigen Anselwennung der mermational Australiam Abkammen und gegenseltigen Anselwennung der mermational Laberature Aszerbätzlich (E.A.), des International Accreditation Fort m (IVI) und der mermational Laberature Aszerbätzlich un Gauppenstelle (ILAC). Die Unternachner eileser Abkammen erkennen ihre Akkreditierungen gegenseltig un.

Der üktue le Stund der Wilgliedschaft kann folgenden Webseiten entnommen werden: FA: www.nuropean-accred fation.org HAC: www.life.org IAR: www.life.org

Note:

The current certificate including annex is published on our website (see link below) or may be received from CETECOM ICT Services on request.

http://www.cetecom.com/eu/de/cetecom-group/europa/deutschland-saarbruecken/akkreditierungen.html